

**Search Notes**

Application/Control No.

10/676,576

Examiner

Sargon N. Nano

Applicant(s)/Patent under  
Reexamination

WU ET AL.

Art Unit

2157

**SEARCHED**

Class	Subclass	Date	Examiner
709	224, 225 229, 240	2/15/2007	SN
370	235, 229	2/15/2007	SN
370	239.1	2/15/2007	SN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see attached report)	2/15/2007	SN
Consulted with John Follansbee	2/15/2007	SN